Semiconductor Device Test Set - Page 1 of 1



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Major Components:

Protector test set; leads

Electrical Power Source Relationship:

Operating

Internal Battery Accommodation:

Included

Inclosure Feature:

Single item w/housing

Test Type For Which Designed:

Provides the capability to evaluate the terminal protection devices used on digital logic signal lines

Operating Test Capability:

Open circuit voltage rate of rise 200 v/s, 1000v/s; max output voltage 1000 v; usable measuring range 0-1000 v; test current for solid state protectors 1 milliamp porm 10 pct; test current for gas tubes greater than 1 amp, less than 20 milliamp

Special Features:

Requested name surge protector test set

Reference Data And Literature:

Serd462

Relationship To Similar Equipment:

Gsimilar to joslyn surge protector test set 4010-01 with usable measuring range of 10-1000 v; p/n 4010-01-m uses select components and an additional calibration step to support measurements of 0-1000 v

Shelf Life:

N/a

Unit Of Measure:

Demilitarization:

Yes - demil/mli

Fiig:

T228-a